


<b>Search Notes</b>  	<b>Application/Control No.</b>  10587617	<b>Applicant(s)/Patent Under Reexamination</b>  LEIGRAF ET AL.
	<b>Examiner</b>  Binh X Tran	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
427	420, 424, 428.08,	12/16/2009	BT
162	119, 135	12/16/2009	BT

SEARCH NOTES		
Search Notes	Date	Examiner
Search inventor's names	12/16/2009	BT
Search keywords using databases in EAST	12/16/2009	BT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--